

Search Notes

Application/Control No.

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Examiner

Maikhanh Nguyen

Applicant(s)/Patent under
Reexamination

DUNCAN ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
715	512 513	8/16/2007	MK
	517 541	8/16/2007	MK
382	186	8/16/2007	MK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Name Search	5/31/2007	MK
NPL (IEEE)	5/31/2007	MK
West Search (USPAT, USPGPub, EPO, JPO, DERWENT) - See Search History Printout	8/16/2007	MK